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Preparation of structurally colored films assembled by Polystyrene@Silica, air@Silica and air@Carbon@Silica core-shell nanoparticles with enhanced color visibility

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Abstract

PS (Polystyrene)@SiO₂ (Silica) core-shell nanospheres were synthesized through a surfactant-free method followed with a modified Stöber method in this work. Hollow SiO₂ was obtained by calcining the PS@SiO₂ core-shell nanoparticles (NPs) at 500 °C in air and air@C(Carbon)@SiO₂ was prepared by calcining PS@SiO₂ in argon. SEM, TEM were used to confirm the formation of homogeneous SiO₂ shell on the negatively charged PS beads. EDS element mapping was utilized to confirm the existence and homogeneity of C layer in the air@C@SiO₂ nanospheres. After calcination, C was partly remained inside the SiO₂ shell and function as absorb materials. The advantages of using negatively charged PS beads to prepare PS@SiO₂ core-shell NPs and calcination PS@SiO₂ in argon to prepare hollow SiO₂ are: (1) the lower cost compared with the positively charged PS beads, since the negatively charged PS beads could be obtained with using cheap anionic initiators (such as KPS); (2) The color saturation of the photonic crystals (PCs) composed by hollow SiO₂ is significantly enhanced without disturbing PCs arrays when the calcination process is carried out in argon. Hollow SiO₂ PCs with enhanced color saturation will enrich the application¹ of core-shell structures in many fields such as bionic colors, paintings,

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cosmetics, and photonic papers.

Keywords: Hollow SiO₂, air@C@SiO₂, calcination, argon protection, enhanced color saturation.

1. Introduction

Photonic crystals (PCs) with the presence of a photonic stop band have many potential technological applications, such as optical communications, photonic computing, switching, sensing, lasing, and solar cells.¹⁻⁹

SiO₂ as a primary component of soil has been widely used to fabricate PCs. Moreover, toxicity of silica particles that are greater than 300 nm in diameter had not been found in vivo. And sub-micrometer sized SiO₂ NPs become one of the best candidates for fabricating the environmental friendly materials.¹⁰⁻¹¹

Brilliant PCs structural color is arising from interference, diffraction, or scattering in periodic arrays according to the Bragg Equation in visible region.¹²⁻¹⁴ Recently, PCs assembled by hollow spheres with novel geometry structures have received considerable attentions. And PCs of hollow spheres were expected to be used as support to synthesize materials with full photonic band gaps.¹⁵⁻²⁰ Core-shell NPs is one of the new building blocks for fabricating PCs with photonic properties vary from those single materials.²¹ To obtain hybrid, multi-functional colloidal NPs, core-shell NPs provide a simple way to incorporate different materials into the same structure.²²⁻²⁵ As a widely used coating material, SiO₂ has many advantages: First, SiO₂ is hydrophilic and negatively charged, which can prevent the aggregation of the colloidal particles; second, hollow SiO₂ could be easily obtained by removing the core via calcination or etching.²⁶⁻³²

Negatively charged Polystyrene (PS) beads with uniform spherical shape become one of the

widely used template materials. Moreover, it could be obtained by using cheap anionic initiators (e.g., KPS) and the cost of which is lower compared to the positively charged PS beads.^{26-27, 33} Stöber method could be employed to fabricate SiO₂ coating on PS, if one handles the surface charge properly.^{34-35, 37-40} In general, negatively charged PS beads were not suitable to be used as core materials for the deposition of SiO₂ on them directly, due to the existence of strong electrostatic repulsive force.^{35, 36} And SiO₂ particles were tend to independently existed in the ethanol solution instead of depositing on the surface of negatively charged PS beads. However, Jiang et al.³⁶ found that SiO₂ shell could be coated on the surface of negatively charged PS beads with the help of a nonionic surfactant (such as PVP), but this method involves several steps. Most recently, Deng et al.³⁵ reported homogeneous PS@Vinyl-SiO₂ core-shell particles by using Vinyl silane three oxygen radicals (VTMS) as a precursor of SiO₂, and high yield of SiO₂ coating on negatively charged PS beads was obtained in this way. However, expensive raw material was not suitable for mass production. Previously, Xia and co-workers³⁴ also reported a simple one-step method to prepare the PCs of PS-core SiO₂-shell spheres by selecting the PS spheres terminated in the -NH₂ group. In addition, color saturation is also very important for PCs. But PCs assembled by hollow spheres usually have a low color visibility since there is only a thin layer of high refractive index material and induced a small effective modulation of the refractive index.¹⁵

Black materials with high absorption in visible region could be used to enhance the color saturation and the color saturation could be enhanced significantly by mixing black materials of several nanometers (such as acetylene black and Fe₃O₄) into colloidal systems.⁴¹⁻⁴⁵ But this method is not suitable for preparing PCs since they were tended to cause defects and break down the long range order inevitably.

Herein, homogeneous PS@SiO₂ core-shell NPs were prepared by a simple surfactant-free method and a modified Stöber method. Air@SiO₂ and Air@C@SiO₂ were obtained by calcining the PS@SiO₂ at 500 °C in air and argon, respectively. The advantages of using negatively charged PS beads to prepare PS@SiO₂ core-shell NPs and calcination PS@SiO₂ in argon to prepare hollow SiO₂ are: (1) the lower cost of negatively charged PS beads compared with the positively charged PS beads, since the negatively charged PS beads could be obtained by using cheap anionic initiators (such as KPS); (2) The color saturation of PCs assembled by hollow SiO₂ is significantly enhanced without disturbing PCs arrays when calcination process is carried out in argon. PCs of air@C@SiO₂ with enhanced color saturation will enrich the application of core-shell structure in many fields such as bionic colors, paintings, cosmetics, and photonic papers.

2. Experimental Sections

2.1. Chemicals and Materials

Styrene (St), sodium hydroxide (NaOH), potassium persulfate (KPS), Tetraethoxysilane (TEOS), ethanol, and ammonia (28%) were purchased from Sinopharm Chemical Reagent Co., Ltd of China. Concentrated sulfuric acid (H₂SO₄) (96%), methacrylic acid (MAA) and hydrogen peroxide (H₂O₂) (30%) were all purchased from Tianli Chemical Reagent Co., Ltd., China. St was extracted by washing with aqueous NaOH (5 wt %) for three times, followed by deionized water for six times, respectively. Other reagents of analytically grade were directly utilized without further purification. Deionized water (18.2 MΩ. cm resistivity) was used in all experiments. The glass substrate was treated in a mixture containing concentrated 98% H₂SO₄ and 30% H₂O₂ with a volume ratio of H₂SO₄/H₂O₂ = 3:1 v/v) at 60 °C for 2 h before use.

2.2. Synthesis of PS NPs.

Emulsifier-free emulsion polymerization method was used to synthesize PS NPs. In a typically process, polytetrafluoroethylene stirring rod was fixed on a 250 ml three-neck round-bottomed flask in an oil bath. 100.0 ml deionized water, 6.0-8.0 ml St and 1ml of MAA were added into the flask at room temperature and slowly heated to 75.0 °C under a speed of nearly 300 rpm. Then, 5.0 ml of deionized water containing 0.15 g KPS was poured into the flask as quickly as possible. Experiment was carried out under nitrogen atmosphere and kept at the constant temperature for 8 h. Finally, the PS suspension was washed with ethanol for three times and stored in ethanol for use.

2.3. Preparation of monodisperse PS@SiO₂ spheres.

Generally, PS beads terminated in -SO₃H or -COOH group were considered to be negatively charged. And it is hardly to develop SiO₂ coating directly on PS nanospheres with a negative charge on surface. However, PS beads terminated in the -NH₂ group were considered to be slightly positively charged or essentially neutral, which could be easily coated with uniform shells of amorphous silica by controlling the hydrolysis and condensation of TEOS precursor.

In this study, SiO₂ shell was prepared by a modified Stöber procedure involves the slow hydrolysis and condensation of TEOS. In a typical synthesis, 0.03 g PS nanospheres completely dispersed in a mixture of 2 mL deionized water and 35 mL ethanol by ultrasonic. To make PS nanospheres terminated in -NH₂ group, 0.5 mL ammonia was added into the reactor under constant stirring for 60 min. Then, various amounts of TEOS (as specified in each figure caption) were poured into the flask as quickly as possible. The hydrolysis reaction was allowed to proceed at room temperature for 8 h under constant magnetic stirring. Finally, the colloidal dispersions were collected by centrifugation. Due to the negative charges on the surface of silica shells, the core-shell particles

could form stable suspensions in aqueous mediums without adding any surfactant.

2.4. Crystallization of the Core-Shell nanospheres.

3D PCs of PS and PS@SiO₂ spheres were fabricated by using a simple vertical deposition method.¹⁵ In a typical process: first, about 0.01-0.02g dried PS powder or 0.02-0.04g PS@SiO₂ powder were dispersed in 10 ML of ethanol by ultrasonic for 30 min at ambient temperature. Then those dispersions were poured into a 25 ML beaker and glass substrates were carefully placed into the beaker. The whole process was carried out at 40 °C for PS and 50 °C for PS@SiO₂.

2.5. Fabrication of silica shell PCs.

PCs of hollow SiO₂ were acquired by calcining PS@SiO₂ at 500 °C. The calcination process in detail was described as follow: the PCs samples were calcined at 500 °C in a rate of 3 °C /min and kept at 500 °C for 2 h in argon protection. For comparison, we also calcined the samples in air. Finally, the samples were natural cooling in the furnace.

2.6. Characterization.

Transmission electron microscope (TEM) (FEI Tecnai G2 F20 S-TWIN) was used for observing the morphology and measuring the geometric parameters of the particles. The samples were prepared by dipping a carbon coated copper grid into a diluted ethanol solution of particles, taking out the copper grid, and evaporating the ethanol solvent.

The morphology of colloidal crystal films was observed by using scanning electron microscopy (SEM) (Hitachi S4800). A thin Au layer (10 nm) was sputtered on the film before observing. The reflection spectra of the colloidal crystals were recorded by using a Cary 5000 UV-vis-NIR spectrometer (Agilen).

The optical photographs and microscopy images of the fabricated APSs were taken by an optical

microscope (Leica DM2500 M) connected with a CCD camera.

The diameter of PS spheres, PS@SiO₂ spheres and hollow silica spheres were determined by a statistical method. For example, the mean diameter of spheres was obtained by statistical diameter about 30 spheres from the SEM images. The inner diameter of hollow silica spheres and the thickness of silica shells were also determined by the statistical method from TEM images.

¹H NMR spectra were taken on a Bruker AV400 nuclear magnetic resonance spectrometer (NMR) with a proton frequency of 300 MHz and the solvent was DMSO-d₆. FTIR spectra were recorded with Agilent FTIR8400S Fourier Transform Infrared spectrometer in KBr pellets between 6000 and 20 cm⁻¹ in air.

3. Results and discussion.

3.1 Characterization of PS@SiO₂ spheres and photonic crystal films

In this study, PS templates of 180±5 nm, 200±5 nm, 240±5 nm, and 290±5 nm in size with a low polydispersity have been synthesized in advance. SEM images in Fig. S1 indicate that the as-prepared PS spheres with a monodisperse character are suitable to be used as templates. PS@SiO₂ spheres were prepared by coating SiO₂ on those PS beads terminated in -NH₂ group. And the shell thickness was controlled by adjusting the concentration of TEOS. All of the reactions were carried out at the same ammonia concentration under constant stirring. The formation procedure of PS@SiO₂, air@SiO₂ and air@C@SiO₂ core-shell NPs are illustrated in Scheme 1. The measured diameter of PS, PS@SiO₂ nanospheres, corresponding reflection peaks and shell thickness are summarized in Table 1.

Fig. 1 shows the SEM images of PS@SiO₂ NPs with different sizes. The PS@SiO₂ NPs are monodisperse with uneven surface compared to the pure PS beads. And the surface roughness of

PS@SiO₂ confirms the formation of silica shell on PS beads. Moreover, free standing SiO₂ particles are absent in the production. For comparison, SEM images in Fig. S2 shows the SiO₂ coated PS and NH₃·H₂O modified PS NPs, respectively. When pure PS beads are used as core material, immobilized SiO₂ and freestanding SiO₂ particles are coexisted in the production indicating that SiO₂ could hardly coated on negatively charged PS beads directly (Fig. S2a). When the negatively charged PS beads have been modified by NH₃·H₂O before coating, the surface of PS beads are fully occupied by the immobilized SiO₂ particles and freestanding SiO₂ particles were absent in the production (Fig. S2b).

The shell thickness of SiO₂ is strongly depends on the concentrations of TEOS, and the shell thickness is increased with the concentration of TEOS. PS beads terminated with -NH₂ group could change their surfaces charge from negative into neutral (or slightly positive-charged) and silica sols could easily nucleated on the surface of each PS beads and eventually merge and grow into a thin shell characterized by uniform thickness.

FTIR spectra of the PS NPs and the ammonium treated PS are shown in Fig. 2a. The characteristic bands of PS could be observed in both of the samples: C-H stretch around 3000 cm⁻¹, aromatic C-C stretch around 1470 cm⁻¹, C-H out-of plane bend at 765 cm⁻¹, and aromatic C-C out-of-plane bend at 700 cm⁻¹. The characteristic absorption of the amino group at 3404 cm⁻¹ indicates the existence of -NH₂ in the ammonium treated sample.

¹H NMR was also used to confirm the existence of -NH₂ on PS NPs. Fig. 2b shows the ¹H NMR spectra and the proton attached to the primary amine (-NH₂) is observed at 7.2 ppm.

Fig. S3 show the electrophoretic measurement results of pure PS beads and -NH₂ terminated PS beads and the colloidal stability were apparent from electrophoretic measurements. The decrease

in electrophoretic mobility from -0.6914 to $-0.2941 \mu\text{m}\cdot\text{cm}/\text{Vs}$ indicate the successful of $-\text{NH}_2$ group anchored on the surface of PS NPs. A change in the zeta potential of the particles is observed from approximately -33.3 mV for a bare PS surface to -14.17 mV. Thus, the $-\text{NH}_2$ is successfully anchor on the surface of PS NPs.

The measured zeta potentials for the PS, PS@SiO₂ NPs are approximately -33.3 mv and -31.48 mv, respectively. And the zeta potential is high enough for the suspension to keep stable for several hours. Fig. S4 shows the transmittance changes of the PS@SiO₂ solution over times. The PS@SiO₂ sample (Fig. S4a) appeared very stable over 26 hours and the transmittance has only a little change (Fig.S4b). Thus, the homogeneous PS@SiO₂ spheres could be utilized to fabricate three dimensional (3D) PCs.

Fig. 3 displays the SEM image of large-scale domains of PS@SiO₂ crystalline arrays with dimensions approximately 20 μm . The crystalline arrays are ordered 3D hexagonal close-packed structures. And both of the six-fold symmetry and high degree of crystalline order are reflected in the FFT spot pattern (shown in the insert of Fig. 2).Where peaks up to third orders are clearly present although some defects still exist in the crystalline arrays. The formation of defects maybe resulted from the evaporating of water molecule and hydroxyl group on the surface of PS@SiO₂ spheres during self-assembly and thermal treatment process.³⁷

3.2. Air@C@SiO₂ nanospheres

The TEM images of various core-shell particles prepared at different TEOS concentration are shown in Fig. 4. For example, the PS@SiO₂ spheres with the core size of 180 nm, 200 nm, 240 nm and 290 nm are coated on silica shells with thicknesses of 20 nm, 25 nm, 30 nm and 25 nm in different TEOS concentration, respectively. The particle size and shell thickness of the core-shell

particles after calcination are listed in Table S2 (supporting information).

Traditional way for fabricating PCs of hollow shells involves two steps: first, the formation of colloidal crystals of core-shell particles and followed with the removal of organic core by corrosion or calcination. In this study, air@C@SiO₂ core-shell spheres were obtained by calcining the PS@SiO₂ PCs at 500 °C for 2 h in argon, PCs of PS@SiO₂ calcined at 500 °C for 2 h in air has also been prepared for comparison. PS cores were burned away when calcined in air while part of the carbon still remained inside the shell as absorb layers when calcination was carried out in argon. Thereby, bi-layer core-shell nanospheres composed by a thin carbon layer exist in the interior of silica shell was generated.

EDS element mapping of air@C@SiO₂ NPs in Fig. 5 is utilized to show the space distribution of Si, O, and C elements. The intense Si and O signals throughout the shells suggest that the SiO₂ shell is homogeneous. The enhanced C signals in the internal edge of SiO₂ shell manifest that the carbon black is originated from PS NPs.

3.3. Optical properties of PS, PS@SiO₂ and hollow SiO₂ photonic crystals

The microscopic images of PCs structurally colored films and the corresponding reflective spectra are shown in Fig. 6. The peak positions shift to longer wavelength as the shell thickness increased and the shift trend of reflection spectra is agree very well with others work.²⁵ The changes in reflection peak positions are resulted from the variation of inter-planar spacing and effective refractive index. The Bragg law is given by Eq (1)^{34, 46-47}:

$$m\lambda_{\text{peak}} = 2d_{\text{hkl}} \left[n_{\text{eff}}^2 - \sin^2 \theta \right]^{1/2} \quad (1)$$

Where m is the order of diffraction, λ_{peak} is the wavelength of the reflection peak, d_{hkl} is the inter-planar spacing between (h k l) planes, n_{eff} is the effective reflective index of the crystalline

lattice, θ is the light incident angle. Generally, the (1 1 1) planes of photonic crystals are oriented parallel to the surface of the glass substrate. In the spectra measurements, we suppose that the direction of incident light perpendicular to the (1 1 1) planes ($\theta = 0$). In the FCC structure, the inter-planar spacing of d_{111} is shown in Eq. (2):

$$d_{111} = \left(\frac{2}{3}\right)^{1/2} D_{sphere} \quad (2)$$

where D_{sphere} is the diameter of the sphere. For a close packed structure n_{eff} is given by Eq. (3):

$$n_{eff} = \left[n_{sphere}^2 f + n_{air}^2 (1-f)\right]^{1/2} \quad (3)$$

Where n_{sphere} and n_{air} are the refractive index of PS spheres and air, respectively; f is the volume fraction of spheres.

For the PS@SiO₂ spheres, n_{sphere} can be calculated by using Eq. (4)

$$n_{sphere} = n_{PS} \frac{V_{PS}}{V} + n_{SiO_2} \frac{V_{SiO_2}}{V} \quad (4)$$

where n_{PS} and n_{SiO_2} are the refractive index of PS and SiO₂ spheres; V_{PS} and V_{SiO_2} are the volumes of PS and SiO₂ spheres; V is the total volume of each component ($V = V_{PS} + V_{SiO_2}$). We assume that $n_{SiO_2} = 1.46$, $n_{PS} = 1.59$ and $f = 0.74$ for a closed-packed FCC structure.¹⁷

Thus, For PS NPs,

$$\lambda = 2.382D_{sphere}$$

And for PS@SiO₂ PCs,

$$n_{ps@SiO_2} = 1.46 + 0.13 \times (r/R)^3$$

The reflection peak positions of PCs assembled by PS and PS@SiO₂ NPs in Fig. 7 indicate that there are some discrepancies exist between the calculated and measured values. And the above-mentioned difference could be resolved by taking defects of the PCs into account. Fig. 3 shows that some defects still exist in the PCs although the ordered packing of the PCs is

characterized by hexagonal close-packed arrays. Thus, the volume of the sphere is partly replaced by the solvent or air and the effective refractive index of the PCs is lower than 0.74.

Fig. 8 shows the variation tendency of reflection peak positions for different PCs films. And the stop band of the hollow SiO₂ PCs have an obvious blue-shift due to the decrease of effective refractive index (n_{eff}) and particle size during calcination when compared with PCs assembled by PS and PS@SiO₂. In order to theoretically calculate the Bragg diffraction peak, the Eq. (4) should be modified by using Eq. (5):

$$n_{\text{sphere}} = n_{\text{air}} \frac{V_{\text{air}}}{V} + n_{\text{SiO}_2} \frac{V_{\text{SiO}_2}}{V} \quad (5)$$

Where n_{air} is the refractive index of air; V_{air} is the volumes of air; V is the total volume of each component ($V = V_{\text{air}} + V_{\text{SiO}_2}$). We assume that $n_{\text{air}} = 1$ and $n_{\text{SiO}_2} = 1.46$.¹⁹

3.4 Photonic crystal of air@C@SiO₂ with enhanced color saturation

When calcination process was carried out in air, the sample shows an extremely weak color appearance. However, the color saturation was significantly enhanced while calcination process was carried out at 500 °C in argon. Fig. 9 shows the images of colored films and PCs domains assembled by air@C@SiO₂ NPs. Because the absorb materials originated from the carbonization of PS make the multiple scattering of lights reduced considerably while the reflection intensity caused by coherent scattering only slightly decreased. In this way, the color saturation could be enhanced significantly without disturbing the PCs arrays. In addition, PCs calcined in air and argon have the same color appearance, indicating that the black material originated from PS just absorb the incoherent scattering light and no contribution to the structural colors. Interestingly, the colorful PCs samples in powder form still possess brilliant structural colors (shown in Fig. 10), which could be used as physical pigments.

Conclusion

PS@SiO₂ core-shell nanoparticles with shell thickness ranging from 20 to 30 nm by coating uniform shells of amorphous silica on polystyrene beads which terminated with -NH₂ groups have been prepared. And the particle sizes could be easily controlled by manipulating the hydrolysis and condensation of the TEOS precursor. 3D PCs of PS and PS@SiO₂ were fabricated via vertical deposition. The PS cores were burned away when calcination in air while part of the carbon still remained inside the shell when calcination at 500 °C in argon. And bi-layered nanospheres composed of a carbon black layer in the interior of the silica shell were generated. Most importantly, the visibility of this hollow SiO₂ PCs was significantly enhanced without disturbing the PCs arrays when calcination was carried out in argon. And the black materials originated from PS just absorb incoherent scattering light and no contribution to the color appearance. This method will be widely spread to improve the color saturation without disturbing the PCs. Moreover, hollow SiO₂ photonic crystal with high color saturation will enrich the application of core-shell NPs in many fields such as bionic colors, paintings, cosmetics, and photonic papers.

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Figure Captions:

Scheme 1. Particle formation, colloidal crystal self-assemble and calcination of PS@SiO₂ and air@C@SiO₂ PCs.

Figure 1. PS@SiO₂ spheres prepared by coating uniform amorphous silica on different PS NPs:

a)220nm ±5; b)250nm ±5; c)300nm ±5; d)340nm ±5.

Figure 2. (a) Infrared spectra (FTIR) of PS NPs and the ammonium -treated NPs. (b) 1H NMR spectra of the -NH₂ modified PS.

Figure 3. SEM images of large-scale domains of PS@SiO₂ crystalline arrays with hexagonal close-packed structures. The insert in Fig. 2: FFT spot pattern of a single crystal domain.

Figure4. the TEM images of various core-shell particles prepared at the same TEOS concentration. For example, the PS@SiO₂ spheres with the core size of 180 nm, 200 nm, 240 nm and 290nm were coated on silica shells with thicknesses of 20 nm, 25nm, 30nm and 25 nm were fabricated at the same TEOS concentration, respectively.

Figure 5. EDX element mapping of the identical NPs of air@C@SiO₂ and air@ SiO₂.

Figure 6. Microscopic image (reflective model: a1-a2: colloidal crystal film of PS180, PS@SiO₂ 220 nm; b1-b2: PS200, PS@SiO₂ 250nm; c1-c3: PS240, PS@SiO₂ 260 nm, PS@SiO₂ 300nm; d1-d3: PS290, PS@SiO₂ 310nm, PS@SiO₂ 340nm;A-D is the corresponding reflective spectra of PCs of PS and PS@SiO₂ spheres at normal incidence.

Figure 7. The calculated and experimental reflection peak positions of PS and PS@SiO₂ PCs. Exp and cal represent the experimental and calculate, respectively.

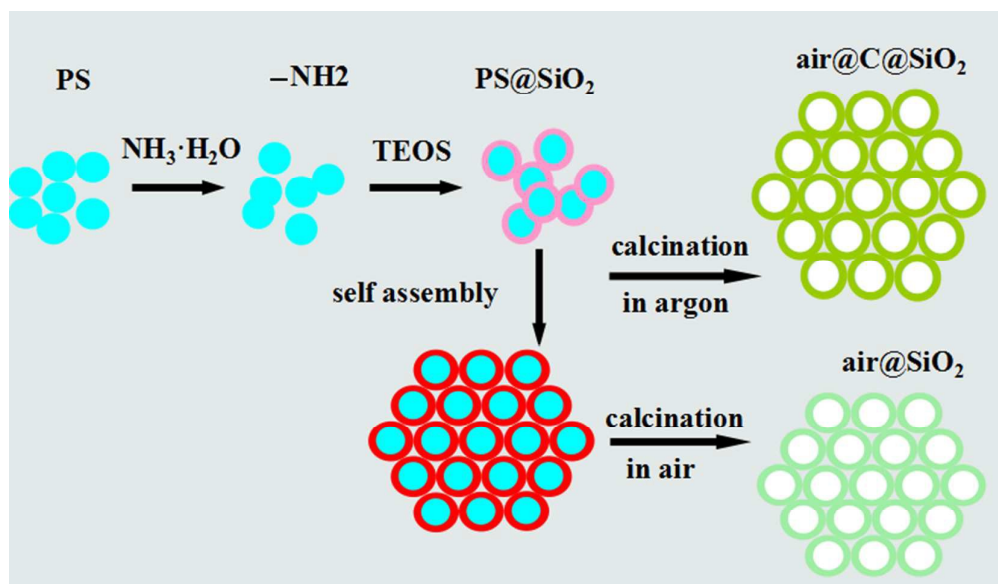
Figure 8. Tendency of reflection peak positions of photonic crystal films.

Figure9.The optical images of colored films and photonic crystal domains of air@C@SiO₂ nanospheres. A. air@C@SiO₂ 220 nm; B. air@C@SiO₂ 250 nm; C. air@C@SiO₂ 300 nm; air@C@SiO₂340 nm. The core size from A-D is 180 nm, 200 nm, 240 nm; 290 nm, separately.

Figure10. Photonic crystal domains of PS@SiO₂ NPs calcination at different environment. A-D:

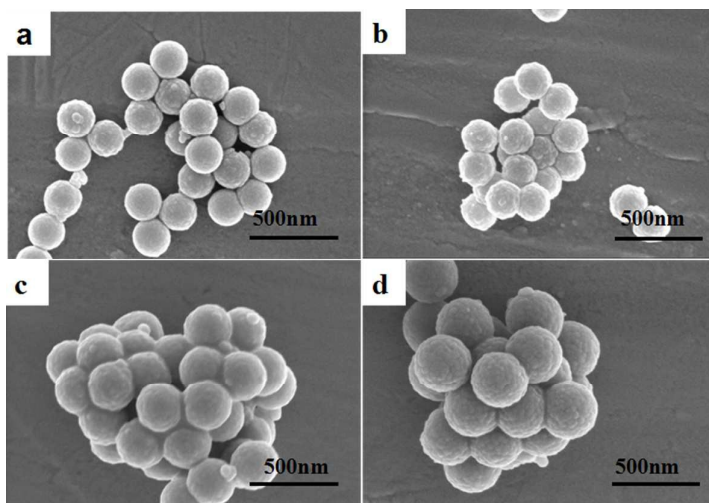
Calcination under argon protection. A'-D': Calcination in air. A. PS@SiO₂ 220 nm; B. PS@SiO₂ 250 nm; C. PS@SiO₂ 300 nm; PS@SiO₂ 340 nm. The core size from A-D is 180 nm, 200 nm, 240 nm; 290 nm, respectively.

Scheme 1.



Scheme 1. Particle formation, colloidal crystal self-assembly and calcination of PS@SiO₂ and

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Figure 1.**Figure 1.** PS@SiO₂ spheres prepared by coating uniform amorphous silica on different PS NPs:

a)220nm ±5; b)250nm ±5; c)300nm ±5; d)340nm ±5.

Figure 2.

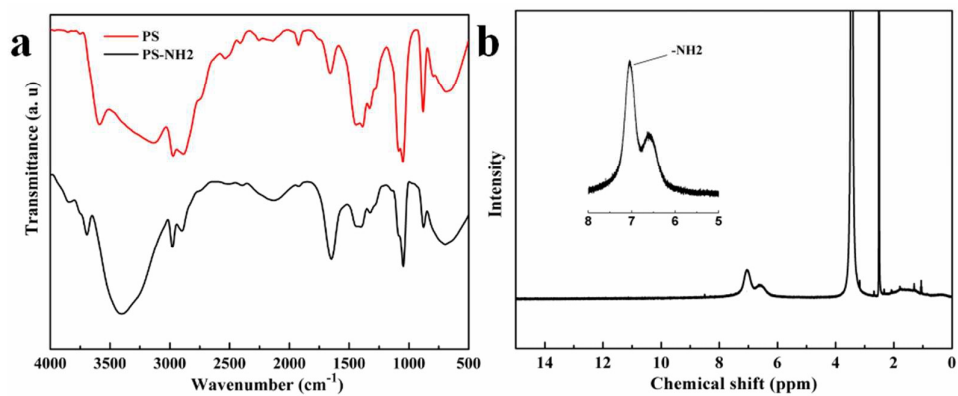


Fig. 2 (a) Infrared spectra (FTIR) of PS NPs and the ammonium -treated NPs. (b) ¹H NMR spectra of the -NH₂ modified PS.

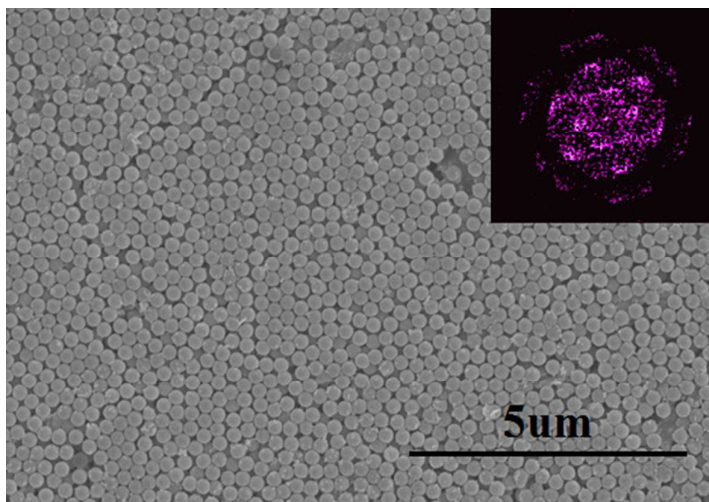
Figure 3.

Figure 3. SEM images of large-scale domains of PS@SiO₂ crystalline arrays with hexagonal close-packed structures. The insert in Fig. 2: FFT spot pattern of a single crystal domain.

Figure 4.

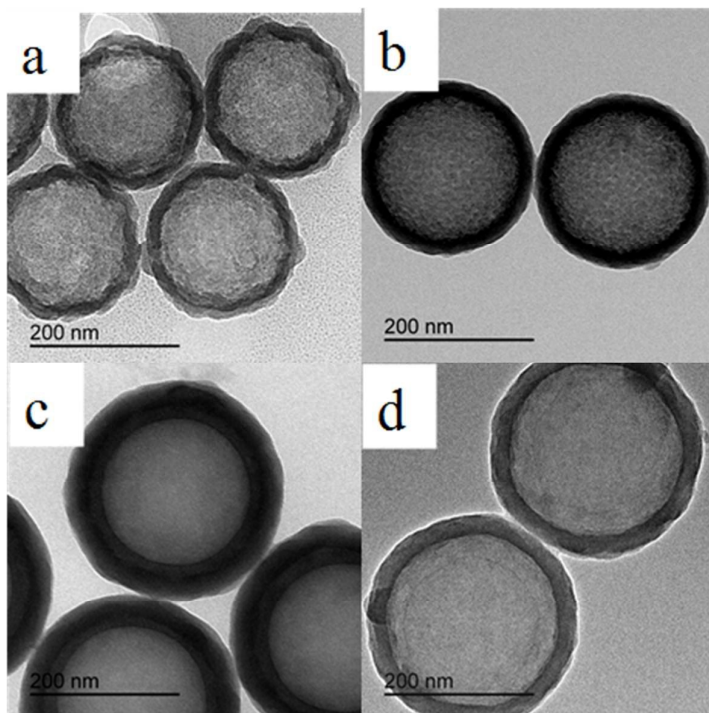


Figure 4. the TEM images of various core-shell particles prepared at the same TEOS concentration.

For example, the PS@SiO₂ spheres with the core size of 180 nm, 200 nm, 240 nm and 290nm were coated on silica shells with thicknesses of 20 nm, 25nm, 30nm and 25 nm were fabricated at the same TEOS concentration, respectively.

Figure 5.

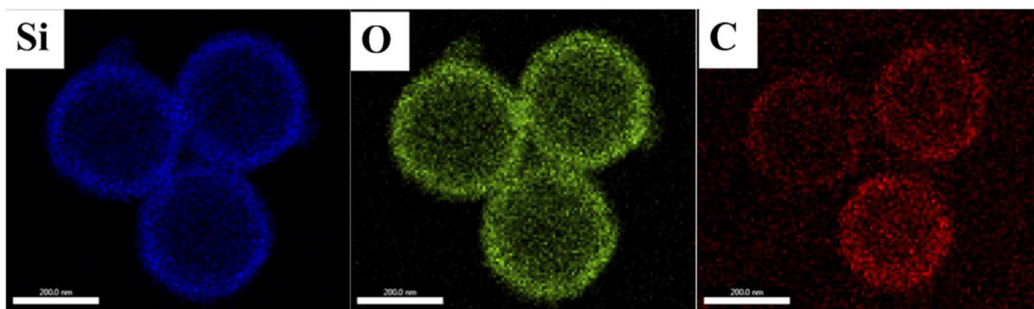


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Figure 6

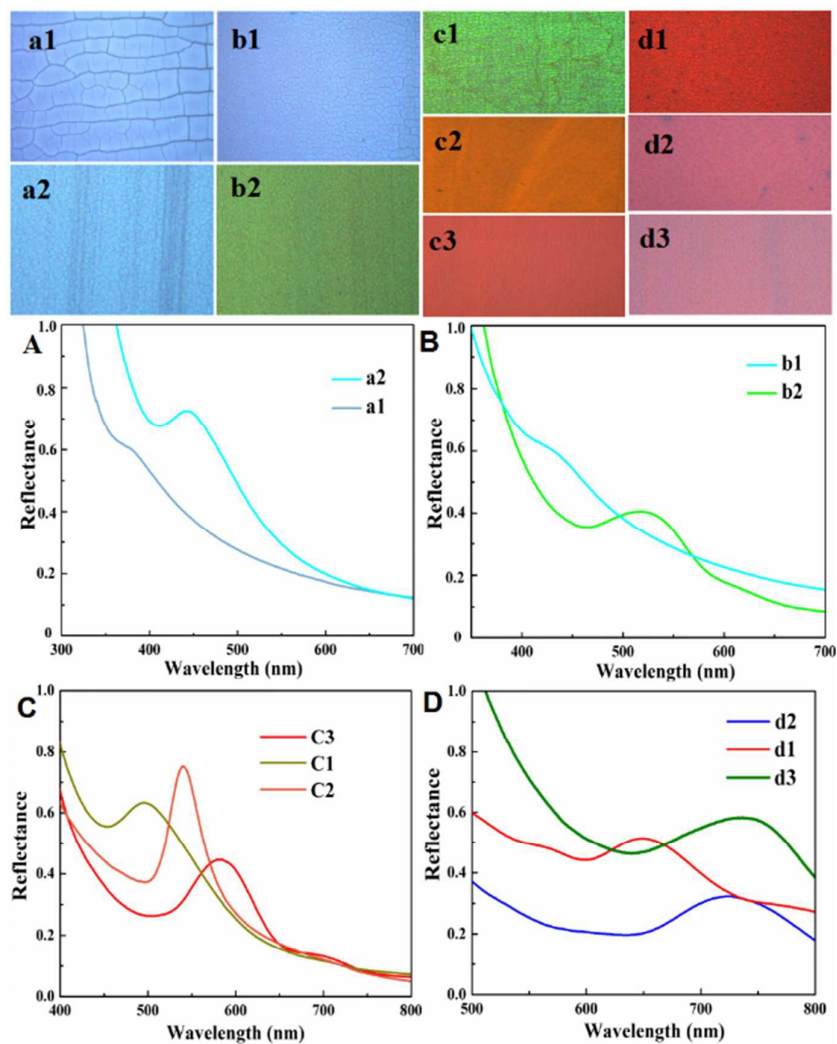


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Figure. 7

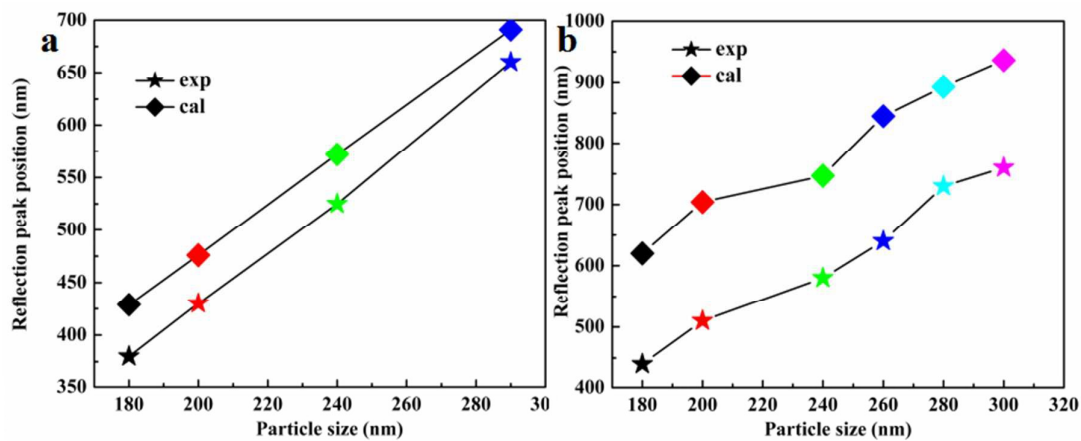


Fig.7 The calculated and experimental reflection peak positions of PS and PS@SiO₂ PCs. Exp and cal

represent the experimental and calculate, respectively.

Figure 8.

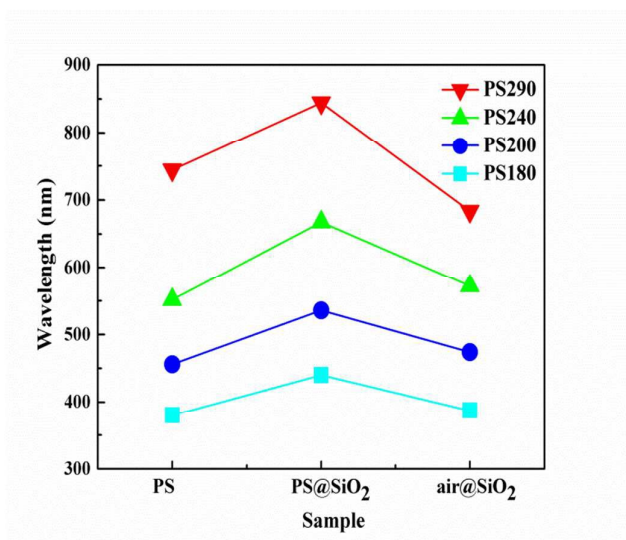


Figure 8. Tendency of reflection peak positions of photonic crystal films

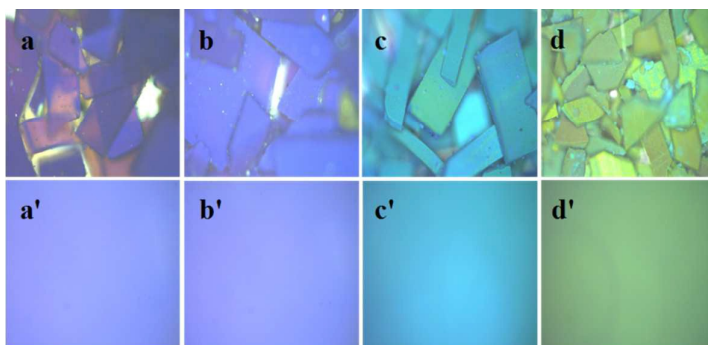
Figure 9.

Figure 9. The optical images of colored films and photonic crystal domains of air@C@SiO₂ nanospheres. A. air@C@SiO₂ 220 nm; B. air@C@SiO₂ 250 nm; C. air@C@SiO₂ 300 nm; air@C@SiO₂ 340 nm. The core size from A-D is 180 nm, 200 nm, 240 nm; 290 nm, separately.

Figure 10.

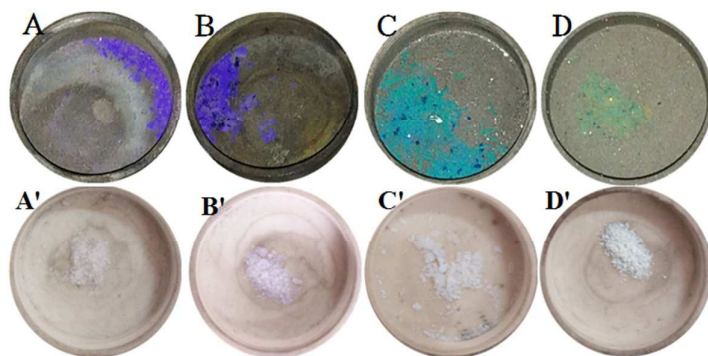


Figure 10. Photonic crystal domains of PS@SiO₂ NPs calcination at different environment. A-D: Calcination under argon protection. A'-D': Calcination in air. A. PS@SiO₂ 220 nm; B. PS@SiO₂ 250 nm; C. PS@SiO₂ 300 nm; PS@SiO₂ 340 nm. The core size from A-D is 180 nm, 200 nm, 240 nm; 290 nm, respectively.

Table 1.

Table 1. diameter and reflection peaks of PS and PS@SiO₂ photonic crystals and shell thickness of hollow SiO₂

sample	Core size (nm)	Ref peak (exp) (nm)	Ref peak (cal) (nm)	C _{TEOS} (uL)	D _{PS@SiO₂} (nm)	Ref peak(x) (nm)	Ref peak(cal) (nm)	Shell size (nm)
1	180±5	380	429	100	220±5	440	620	20
2	200±5	430	476	150	250±5	510	704	25
3	240±5	525	572	150	260±5	580	747	10
				200	300±5	640	845	30
4	290±5	660	691	150	310±5	730	893	10
				200	340±5	760	936	25